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Amendments

In the Claims:

Please cancel claim 6; amend claims 1 and 7-13 as follows:

1. A wiring layer structure connected to a first electrode of a ferroelectric capacitor having first and second electrodes, comprising:

a main wiring layer including a first material that reacts with a substance to produce a reducing agent, said substance being infiltrated from the outside to this main wiring layer; and

a coating layer including a first coating part provided between said main wiring layer and said first electrode, a second coating part provided on the top surface of said main wiring layer, and a third coating part provided on side faces of said main wiring layer;

wherein said coating layer is conductive and comprises a second material for preventing the infiltration of said substance into said main wiring layer.



- 7. The wiring layer structure according to Claim 1, wherein said first, second, and third coating parts are titanium nitride (TiN) films.
- 8. The wiring layer structure according to Claim 1, wherein said first and third coating parts are titanium nitride (TiN) films, and said second coating part is a built-up film composed of a titanium (Ti) film and a titanium nitride (TiN) film.
- 9. The wiring layer structure according to Claim 1, wherein said first coating part is a titanium nitride (TiN) film, and wherein said second and third coating parts are built-up films composed of a titanium (Ti) film and a titanium nitride (TiN) film.
- 10. The wiring layer structure according to Claim 1, wherein said first coating part is a titanium nitride (TiN) sputtering film, and said second and third coating parts are TiN-CVD films.